Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/654,770	PARK ET AL.	
Examiner	Art Unit	
Binh X. Tran	1765	

SEARCHED				
Class	Subclass	Date	Examiner	
438	696	11/14/2005	ВТ	
438	700	11/14/2005	ВТ	
438	710	11/14/2005	вт	
438	718	11/14/2005	ВТ	
	0.000			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
438	696	11/14/2005		
438	700	11/14/2005		
438	710	11/14/2005	•	
438	7718	11/14/2005		

SEARCH NO (INCLUDING SEARC	OTES H STRATEGY	)
	DATE	EXMR
Update search using EAST	11/14/2005	ВТ